Functional Safety Information UCC28740-Q1 Functional Safety FIT Rate, FMD and Pin FMA

TEXAS INSTRUMENTS

Table of Contents

1 Overview	2
2 Functional Safety Failure In Time (FIT) Rates	
3 Failure Mode Distribution (FMD)	
4 Pin Failure Mode Analysis (Pin FMA)	
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1 Overview

This document contains information for UCC28740-Q1 (SOIC (7) package) to aid in a functional safety system design. Information provided are:

- Functional Safety Failure In Time (FIT) rates of the semiconductor component estimated by the application of industry reliability standards
- · Component failure modes and their distribution (FMD) based on the primary function of the device
- Pin failure mode analysis (Pin FMA)

Figure 1-1 shows the device functional block diagram for reference.

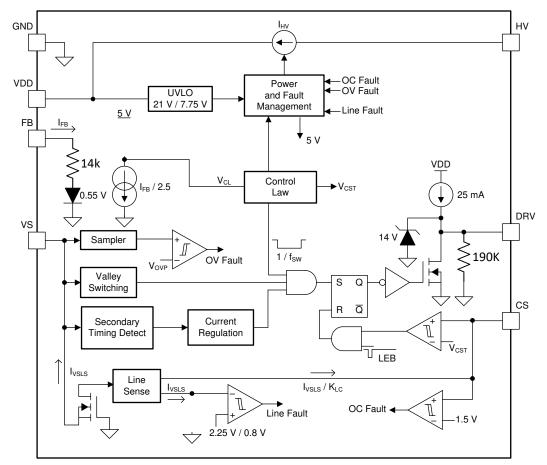


Figure 1-1. Functional Block Diagram

UCC28740-Q1 was developed using a quality-managed development process, but was not developed in accordance with the IEC 61508 or ISO 26262 standards.

2

UCC28740-Q1

Functional Safety FIT Rate, FMD and Pin FMA

2 Functional Safety Failure In Time (FIT) Rates

This section provides Functional Safety Failure In Time (FIT) rates for UCC28740-Q1 based on two different industry-wide used reliability standards:

- Table 2-1 provides FIT rates based on IEC TR 62380 / ISO 26262 part 11
- Table 2-2 provides FIT rates based on the Siemens Norm SN 29500-2

Table 2-1. Component Failure Rates per IEC TR 62380 / ISO 26262 Part 11

FIT IEC TR 62380 / ISO 26262	FIT (Failures Per 10 ⁹ Hours)
Total Component FIT Rate (50 mW, 100 mW, 150 mW)	10, 11, 13
Die FIT Rate (50 mW, 100 mW, 150 mW)	3, 4, 5
Package FIT Rate (50 mW, 100 mW, 150 mW)	7, 7, 8

The failure rate and mission profile information in Table 2-1 comes from the Reliability data handbook IEC TR 62380 / ISO 26262 part 11:

- Mission Profile: Motor Control from Table 11
- Power dissipation: 50 mW, 100 mW, 150 mW
- Climate type: World-wide Table 8
- Package factor (lambda 3): Table 17b
- Substrate Material: FR4
- · EOS FIT rate assumed: 0 FIT

Table 2-2. Component Failure Rates per Siemens Norm SN 29500-2

Table	Category	Reference FIT Rate	Reference Virtual T _J
5	CMOS, BICMOS Digital, analog / mixed	25 FIT	55°C

The Reference FIT Rate and Reference Virtual T_J (junction temperature) in Table 2-2 come from the Siemens Norm SN 29500-2 tables 1 through 5. Failure rates under operating conditions are calculated from the reference failure rate and virtual junction temperature using conversion information in SN 29500-2 section 4.



3 Failure Mode Distribution (FMD)

The failure mode distribution estimation for UCC28740-Q1 in Table 3-1 comes from the combination of common failure modes listed in standards such as IEC 61508 and ISO 26262, the ratio of sub-circuit function size and complexity and from best engineering judgment.

The failure modes listed in this section reflect random failure events and do not include failures due to misuse or overstress.

Die Failure Modes	Failure Mode Distribution (%)
DRV stuck high	17
DRV stuck low	35
Incorrect output regulation	22
No effect	26

Table 3-1. Die Failure Modes and Distribution



4 Pin Failure Mode Analysis (Pin FMA)

This section provides a Failure Mode Analysis (FMA) for the pins of the UCC28740-Q1. The failure modes covered in this document include the typical pin-by-pin failure scenarios:

- Pin short-circuited to Ground (see Table 4-2)
- Pin open-circuited (see Table 4-3)
- Pin short-circuited to an adjacent pin (see Table 4-4)
- Pin short-circuited to supply (see Table 4-5)

Table 4-2 through Table 4-5 also indicate how these pin conditions can affect the device as per the failure effects classification in Table 4-1.

Table 4-1	TI Classification of Failure Effects

Class	Failure Effects
A	Potential device damage that affects functionality
В	No device damage, but loss of functionality
С	No device damage, but performance degradation
D	No device damage, no impact to functionality or performance

Figure 4-1 shows the UCC28740-Q1 pin diagram. For a detailed description of the device pins please refer to the *Pin Configuration and Functions* section in the UCC28740-Q1 data sheet.

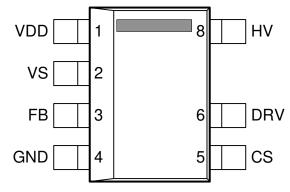


Figure 4-1. Pin Diagram

Following are the assumptions of use and the device configuration assumed for the pin FMA in this section:

- The device is connected according to the design procedure application example shown in Figure 19, in UCC28740-Q1 datasheet
- The supply pin refers to VDD pin

Pin Name	Pin No.	Description of Potential Failure Effect(s)	Failure Effect Class
VDD	1	Device is not functional, system will not startup.	В
VS	2	IC remains in input under voltage protection mode. The output of the flyback converter remains at zero.	В
FB	3	Device operates at its maximum switching frequency with maximum duty cycle. Output OVP is triggered.	В
GND	4	No effect.	D
CS	5	When CS pin is shorted to ground before the IC startup, CS pin short protection. The output of the flyback converter remains at zero.	В
		When CS pin is shorted to ground after the IC in operation, potnetial power stage damange and it might cause IC damage.	A
DRV	6	DRV remains low. The output of the flyback converter remains at zero.	В

Table 4-2. Pin FMA for Device Pins Short-Circuited to Ground

5



_	Table 4	-2. Pin FMA for Device Pins Short-Circuited to Ground (continued)	
Pin Name	Pin No.	Description of Potential Failure Effect(s)	Failure Effect Class
N/A	7		
HV	8	The VDD capacitor cannot be trickle charged and the converter will never startup.	В

Table 4-3. Pin FMA for Device Pins Open-Circuited

Pin Name	Pin No.	Description of Potential Failure Effect(s)	Failure Effect Class
VDD	1	No positive supply applied to device, device is not functional.	В
VS	2	IC remains in input under voltage protection mode. The output of the flyback converter remains at zero.	В
FB	3	Device operates at its maximum switching frequency with maximum duty cycle. Output OVP is triggered.	В
GND	4	Device Damage	Α
CS	5	CS pin open protection. The output of the Flyback converter remains at zero.	В
DRV	6	The output of the Flyback converter remains at zero.	В
N/A	7		
HV	8	The VDD capacitor cannot be trickle charged. Output of the converter remains at zero volts.	В

Table 4-4. Pin FMA for Device Pins Short-Circuited to Adjacent Pin

Pin Name	Pin No.	Shorted to	Description of Potential Failure Effect(s)	Failure Effect Class
VDD	1	VS	VS max voltage rating exceeded, device damaged, possible Flyback switch damage	А
VS	2	FB	FB will not be stable, output voltage will not regulate correctly	С
FB	3	GND	Device operates at maximum switching frequency with maximum duty cycle. Output over voltage protection will be triggered	В
GND	4	N/A		
CS	5	DRV	CS max voltage rating will be exceeded, device damage, possible Flyback switch damage	A
DRV	6	N/A		
N/A	7	N/A		
HV	8	N/A		

Table 4-5. Pin FMA for Device Pins Short-Circuited to supply

Pin Name	Pin No.	Description of Potential Failure Effect(s)	Failure Effect Class
VDD	1	No Effect.	D
VS	2	Pin's maximum voltage rating exceeded, posibble IC damage.	A
FB	3	Pin's maximum voltage rating exceeded, posibble IC damage.	A
GND	4	No positive supply applied to device. Device is non-functional.	В
CS	5	DRV remains low. Possible IC damage.	A
DRV	6	DRV remains high. Possible IC damage and Flyback switch damage.	A
N/A	7		
HV	8	The max rating of VDD will be exceeded, possible device damage and Flyback switch damage.	A

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